Spring-loaded test probe

GKS-075 360 090 A 2000

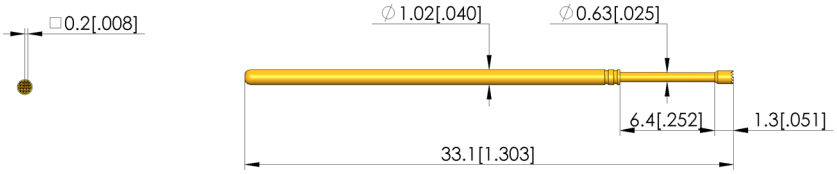
Item GKS-075-0449

GO TO PRODUCT

ingun®
Partner for Future Technology

- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles





General data

Product group:	ICT / FCT (in-circuit test and function test
Sub-product group:	Bead probe
Series:	GKS-075
Grid:	1.91 mm [75 mil]
Contacting from:	Pin, posts, bead
DUT / contact:	Bead probe
Installation type:	Plug-in
Quick-exchange system:	Yes
Adjustable installation height:	No
Non-rotating:	No
Compatible receptacle(s):	KS-075
Min. temperature:	- 40 °C [- 104 °F]
Max. temperature:	+ 80 °C [+ 176 °F]
RoHS-compliant:	RoHS-3;6c

Electrical data

Current load capacity / rated current:	4 A
Typical resistance (Ri):	<20 mOhm

Mechanical data

Total length:	33.1 mm [1.30 in]
Barrel diameter:	1.02 mm [.040 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	0.77 N [2.76 ozf]
Collar height:	00
Spring force at working stroke:	2 N [7.19 ozf]
Recommended working stroke:	4.3 mm [.169 in]

Tip style data

Tip style:	60 serrated, small grid
Tip diameter:	0.9 mm [.035 in]
Tip style surface:	A gold
Tip style material:	3 CuBe

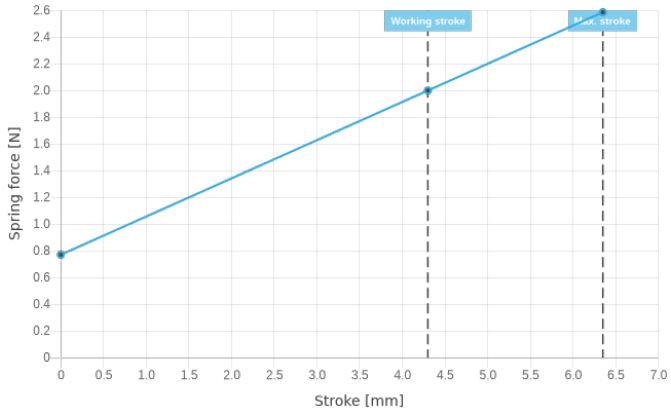
Spring-loaded test probe

GKS-075 360 090 A 2000

Item GKS-075-0449

GO TO PRODUCT

Partner for Future Technology



INGUN Prüfmittelbau GmbH
Max-Stromeyer-Straße 162
78467, Constance, Germany
Phone +49 7531 8105-0
Customer hotline +49 7531 8105-888
Fax +49 7531 8105-65
info@ingun.com

Prices and delivery times on request.
Technical changes reserved. 01/25_GB